－Bidirectional Transceivers
－Meet or Exceed the Requirements of ANSI Standards TIA／EIA－422－B and TIA／EIA－485－A and ITU Recommendations V． 11 and X． 27
－Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments
－3－State Driver and Receiver Outputs
－Individual Driver and Receiver Enables
－Wide Positive and Negative Input／Output Bus Voltage Ranges
－Driver Output Capability ．．．$\pm 60 \mathrm{~mA}$ Max
－Thermal Shutdown Protection
－Driver Positive and Negative Current Limiting
－Receiver Input Impedance ．．． $12 \mathrm{k} \Omega$ Min
－Receiver Input Sensitivity ．．．$\pm 200 \mathrm{mV}$
－Receiver Input Hysteresis ．．． 50 mV Typ
－Operate From Single 5－V Supply

SN65176B ．．．D OR P PACKAGE
SN75176B ．．．D，P，OR PS PACKAGE


## description／ordering information

The SN65176B and SN75176B differential bus transceivers are integrated circuits designed for bidirectional data communication on multipoint bus transmission lines．They are designed for balanced transmission lines and meet ANSI Standards TIA／EIA－422－B and TIA／EIA－485－A and ITU Recommendations V． 11 and X． 27 ．

The SN65176B and SN75176B combine a 3－state differential line driver and a differential input line receiver， both of which operate from a single $5-\mathrm{V}$ power supply．The driver and receiver have active－high and active－low enables，respectively，that can be connected together externally to function as a direction control．The driver differential outputs and the receiver differential inputs are connected internally to form differential input／output $(\mathrm{I} / \mathrm{O})$ bus ports that are designed to offer minimum loading to the bus when the driver is disabled or $\mathrm{V}_{\mathrm{CC}}=0$ ． These ports feature wide positive and negative common－mode voltage ranges，making the device suitable for party－line applications．

ORDERING INFORMATION

| $\mathrm{T}_{\mathbf{A}}$ | PACKAGE $\dagger$ |  | ORDERABLE PART NUMBER | TOP－SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | PDIP（P） | Tube of 50 | SN75176BP | SN75176BP |
|  | SOIC（D） | Tube of 75 | SN75176BD | 75176B |
|  |  | Reel of 2500 | SN75176BDR |  |
|  | SOP（PS） | Reel of 2000 | SN75176BPSR | A176B |
| $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | PDIP（P） | Tube of 50 | SN65176BP | SN65176BP |
|  | SOIC（D） | Tube of 75 | SN65176BD | 65176B |
|  |  | Reel of 2500 | SN65176BDR |  |

$\dagger$ Package drawings，standard packing quantities，thermal data，symbolization，and PCB design guidelines are available at www．ti．com／sc／package．

Please be aware that an important notice concerning availability，standard warranty，and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet．

## description/ordering information (continued)

The driver is designed for up to 60 mA of sink or source current. The driver features positive and negative current limiting and thermal shutdown for protection from line-fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately $150^{\circ} \mathrm{C}$. The receiver features a minimum input impedance of $12 \mathrm{k} \Omega$, an input sensitivity of $\pm 200 \mathrm{mV}$, and a typical input hysteresis of 50 mV .

The SN65176B and SN75176B can be used in transmission-line applications employing the SN75172 and SN75174 quadruple differential line drivers and SN75173 and SN75175 quadruple differential line receivers.

Function Tables
DRIVER

| INPUT <br> D | ENABLE <br> DE | OUTPUTS |  |
| :---: | :---: | :---: | :---: |
|  |  | A | B |
| $H$ | $H$ | $H$ | L |
| L | H | L | H |
| X | L | Z | Z |

RECEIVER

| DIFFERENTIAL INPUTS <br> $\mathbf{A}-\mathbf{B}$ | ENABLE <br> $\overline{R E}$ | OUTPUT <br> $\mathbf{R}$ |
| :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{ID}} \geq 0.2 \mathrm{~V}$ | L | H |
| $-0.2 \mathrm{~V}<\mathrm{V}_{\text {ID }}<0.2 \mathrm{~V}$ | L | $?$ |
| $\mathrm{~V}_{\text {ID }} \leq-0.2 \mathrm{~V}$ | L | L |
| X | H | Z |
| Open | L | $?$ |

$\mathrm{H}=$ high level, $\mathrm{L}=$ low level, ? = indeterminate, $X=$ irrelevant, $Z=$ high impedance (off)

## logic diagram (positive logic)



## schematics of inputs and outputs



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Supply voltage, $\mathrm{V}_{\mathrm{CC}}$ (see Note 1)
functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not
implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. All voltage values, except differential input/output bus voltage, are with respect to network ground terminal.
2. Maximum power dissipation is a function of $T_{J}(\max ), \theta_{\mathrm{JA}}$, and $\mathrm{T}_{\mathrm{A}}$. The maximum allowable power dissipation at any allowable
ambient temperature is $\mathrm{P}_{\mathrm{D}}=\left(\mathrm{T}_{J}(\max )-T_{A}\right) / \theta_{\mathrm{JA}}$. Operating at the absolute maximum $\mathrm{T}_{J}$ of $150^{\circ} \mathrm{C}$ can affect reliability.
3. The package thermal impedance is calculated in accordance with JESD 51-7.
recommended operating conditions

|  |  | MIN | TYP MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| Supply voltage |  | 4.75 | $5 \quad 5.25$ | V |
| Voltage at any bus terminal (separately or common mode) |  |  | 12 -7 | V |
| $\mathrm{V}_{\mathrm{IH}} \quad$ High-level input voltage | D, DE, and $\overline{\mathrm{RE}}$ | 2 |  | V |
| $\mathrm{V}_{\mathrm{IL}} \quad$ Low-level input voltage | D, DE, and $\overline{\mathrm{RE}}$ |  | 0.8 | V |
| Differential input voltage (see Note 4) |  |  | $\pm 12$ | V |
| High-level output current | Driver |  | -60 | mA |
|  | Receiver |  | -400 | $\mu \mathrm{A}$ |
| Low-level output current | Driver |  | 60 | mA |
|  | Receiver |  | 8 |  |
| Operating free-air temperature | SN65176B | -40 | 105 | ${ }^{\circ} \mathrm{C}$ |
|  | SN75176B | 0 | 70 |  |

NOTE 4: Differential input/output bus voltage is measured at the noninverting terminal $A$, with respect to the inverting terminal $B$.

## DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS $\dagger$ |  | MIN | TYP $\ddagger$ | MAX | $\frac{\text { UNIT }}{\mathrm{V}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{IK}}$ | Input clamp voltage | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  |  | -1.5 |  |
| $\mathrm{V}_{\mathrm{O}}$ | Output voltage | $10=0$ |  | 0 |  | 6 | V |
| \|VOD1 ${ }^{\text {l }}$ | Differential output voltage | $\mathrm{I}=0$ |  | 1.5 | 3.6 | 6 | V |
| \|VOD2| | Differential output voltage | $R_{L}=100 \Omega$, | See Figure 1 | $\begin{aligned} & 1 / 2 \mathrm{~V}_{\mathrm{OD} 1} 1 \\ & \text { or } 2 \\| \end{aligned}$ |  |  | V |
|  |  | $\mathrm{R}_{\mathrm{L}}=54 \Omega$, | See Figure 1 | 1.5 | 2.5 | 5 |  |
| VOD3 | Differential output voltage | See Note 5 |  | 1.5 |  | 5 | V |
| $\Delta \mid \mathrm{V}_{\text {OD }}$ | Change in magnitude of differential output voltage§ | $\mathrm{R}_{\mathrm{L}}=54 \Omega$ or $100 \Omega$, | See Figure 1 |  |  | $\pm 0.2$ | V |
| VOC | Common-mode output voltage | $\mathrm{R}_{\mathrm{L}}=54 \Omega$ or $100 \Omega$, | See Figure 1 |  |  | +3 -1 | V |
| $\Delta \mid \mathrm{VOCl}$ | Change in magnitude of common-modeoutput voltage§ | $\mathrm{R}_{\mathrm{L}}=54 \Omega$ or $100 \Omega$, | See Figure 1 |  |  | $\pm 0.2$ | V |
| 10 | Output current | Output disabled, <br> See Note 6 | $\mathrm{V}_{\mathrm{O}}=12 \mathrm{~V}$ |  |  | 1 | mA |
|  |  |  | $\mathrm{V}_{\mathrm{O}}=-7 \mathrm{~V}$ |  |  | -0.8 |  |
| IIH | High-level input current | $\mathrm{V}_{\mathrm{I}}=2.4 \mathrm{~V}$ |  |  |  | 20 | $\mu \mathrm{A}$ |
| IIL | Low-level input current | $\mathrm{V}_{1}=0.4 \mathrm{~V}$ |  |  |  | -400 | $\mu \mathrm{A}$ |
| Ios | Short-circuit output current | $\mathrm{V}_{\mathrm{O}}=-7 \mathrm{~V}$ |  |  |  | -250 | mA |
|  |  | $\mathrm{V}_{\mathrm{O}}=0$ |  |  |  | -150 |  |
|  |  | $\mathrm{V}_{\mathrm{O}}=\mathrm{V}_{\mathrm{CC}}$ |  |  |  | 250 |  |
|  |  | $\mathrm{V}_{\mathrm{O}}=12 \mathrm{~V}$ |  |  |  | 250 |  |
| ICC | Supply current (total package) | No load | Outputs enabled |  | 42 | 70 | mA |
|  |  |  | Outputs disabled |  | 26 | 35 |  |

$\dagger$ The power-off measurement in ANSI Standard TIA/EIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs. $\ddagger$ All typical values are at $\mathrm{V}_{\mathrm{C}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\S \Delta\left|\mathrm{V}_{\mathrm{OD}}\right|$ and $\Delta\left|\mathrm{V}_{\mathrm{OC}}\right|$ are the changes in magnitude of $\mathrm{V}_{\mathrm{OD}}$ and $\mathrm{V}_{\mathrm{OC}}$, respectively, that occur when the input is changed from a high level to a low level.
IT The minimum $\mathrm{V}_{\mathrm{OD} 2}$ with a $100-\Omega$ load is either $1 / 2 \mathrm{~V}_{\mathrm{OD} 1}$ or 2 V , whichever is greater.
NOTES: 5. See ANSI Standard TIA/EIA-485-A, Figure 3.5, Test Termination Measurement 2.
6. This applies for both power on and off; refer to ANSI Standard TIA/EIA-485-A for exact conditions. The TIA/EIA-422-B limit does not apply for a combined driver and receiver terminal.
switching characteristics, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=110 \Omega, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{d}}(\mathrm{OD})$ | Differential-output delay time | $\mathrm{R}_{\mathrm{L}}=54 \Omega$, | See Figure 3 |  | 15 | 22 | ns |
| $\mathrm{t}_{\mathrm{t}(\mathrm{OD})}$ | Differential-output transition time | $\mathrm{R}_{\mathrm{L}}=54 \Omega$, | See Figure 3 |  | 20 | 30 | ns |
| tPZH | Output enable time to high level | See Figure 4 |  |  | 85 | 120 | ns |
| tPZL | Output enable time to low level | See Figure 5 |  |  | 40 | 60 | ns |
| tphz | Output disable time from high level | See Figure 4 |  |  | 150 | 250 | ns |
| tPLZ | Output disable time from low level | See Figure 5 |  |  | 20 | 30 | ns |


| DATA-SHEET PARAMETER | TIA/EIA-422-B | TIA/EIA-485-A |
| :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{O}}$ | $\mathrm{V}_{\text {oa, }} \mathrm{V}_{\mathrm{ob}}$ | $\mathrm{V}_{\mathrm{oa}} \mathrm{V}_{\mathrm{ob}}$ |
| \|VOD1| | $\mathrm{V}_{0}$ | $\mathrm{V}_{0}$ |
| \|VOD2| | $\mathrm{V}_{t}\left(\mathrm{R}_{\mathrm{L}}=100 \Omega\right)$ | $\mathrm{V}_{\mathrm{t}}\left(\mathrm{R}_{\mathrm{L}}=54 \Omega\right)$ |
| \|VOD3| |  | $\mathrm{V}_{\mathrm{t}}$ (test termination measurement 2) |
| ${ }^{\text {\| }}$ VOD ${ }^{\text {d }}$ | $\left\|\left\|V_{t \mid}\right\|-\left\|\bar{V}_{t}\right\|\right\|$ | $\left\|\left\|V_{t}-\left\|\bar{V}_{t}\right\|\right\|\right.$ |
| $\mathrm{V}_{\text {OC }}$ | $\left\|\mathrm{V}_{\text {os }}\right\|$ | \| $\mathrm{V}_{\text {os }} \mid$ |
| $\Delta \mid \mathrm{VOCl}$ | $\left\|\mathrm{V}_{\text {os }}-\overline{\mathrm{V}}_{\text {os }}\right\|$ | $\left\|\mathrm{V}_{\text {os }}-\overline{\mathrm{V}}_{\text {os }}\right\|$ |
| los | \| ${ }_{\text {sal }}$, \| ${ }_{\text {l }}$ sb $\mid$ |  |
| Io |  | ${ }_{\text {lia, }}$, $\mathrm{l}_{\text {ib }}$ |

## RECEIVER SECTION

electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.
NOTE 7: This applies for both power on and power off. Refer to EIA Standard TIA/EIA-485-A for exact conditions.
switching characteristics, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$

| PARAMETER | TEST CONDITIONS | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| tPLH Propagation delay time, low- to high-level output | V ID $=0$ to 3 V , See Figure 6 | 21 | 35 | ns |
| tPHL Propagation delay time, high- to low-level output |  | 23 | 35 |  |
| tPZH Output enable time to high level | See Figure 7 | 10 | 20 | ns |
| tPZL Output enable time to low level |  | 12 | 20 |  |
| tPHZ Output disable time from high level | See Figure 7 | 20 | 35 | ns |
| tpLZ Output disable time from low level |  | 17 | 25 |  |

## PARAMETER MEASUREMENT INFORMATION



Figure 1. Driver $\mathrm{V}_{\mathrm{OD}}$ and $\mathrm{V}_{\mathrm{OC}}$


TEST CIRCUIT


Figure 2. Receiver $\mathrm{V}_{\mathrm{OH}}$ and $\mathrm{V}_{\mathrm{OL}}$


VOLTAGE WAVEFORMS

NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The input pulse is supplied by a generator having the following characteristics: PRR $\leq 1 \mathrm{MHz}, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 6 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 6 \mathrm{~ns}$, $Z_{O}=50 \Omega$.

Figure 3. Driver Test Circuit and Voltage Waveforms

## PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT

NOTES: A. $\mathrm{C}_{\mathrm{L}}$ includes probe and jig capacitance.
B. The input pulse is supplied by a generator having the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 6 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 6 \mathrm{~ns}$, $Z_{O}=50 \Omega$.

Figure 4. Driver Test Circuit and Voltage Waveforms


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The input pulse is supplied by a generator having the following characteristics: PRR $\leq 1 \mathrm{MHz}, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 6 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 6 \mathrm{~ns}$, $\mathrm{Z}_{\mathrm{O}}=50 \Omega$.

Figure 5. Driver Test Circuit and Voltage Waveforms


NOTES:
A. $C_{L}$ includes probe and jig capacitance.
B. The input pulse is supplied by a generator having the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 6 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 6 \mathrm{~ns}$, $\mathrm{Z}_{\mathrm{O}}=50 \Omega$.

Figure 6. Receiver Test Circuit and Voltage Waveforms

## PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS
NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The input pulse is supplied by a generator having the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 6 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 6 \mathrm{~ns}$, $Z_{O}=50 \Omega$.

Figure 7. Receiver Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

DRIVER
HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT


Figure 8

DRIVER
LOW-LEVEL OUTPUT VOLTAGE LOW-LEVEL OUTPUT CURRENT


Figure 9

DRIVER
DIFFERENTIAL OUTPUT VOLTAGE
vs
OUTPUT CURRENT


Figure 10

## TYPICAL CHARACTERISTICS

RECEIVER
HIGH-LEVEL OUTPUT VOLTAGE vs
HIGH-LEVEL OUTPUT CURRENT


Figure 11
RECEIVER
LOW-LEVEL OUTPUT VOLTAGE
vS
LOW-LEVEL OUTPUT CURRENT


Figure 13

RECEIVER
HIGH-LEVEL OUTPUT VOLTAGE
VS
FREE-AIR TEMPERATURE $\dagger$

†Only the $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ portion of the curve applies to the SN75176B.

Figure 12
RECEIVER
LOW-LEVEL OUTPUT VOLTAGE
vs
FREE-AIR TEMPERATURE


Figure 14

## TYPICAL CHARACTERISTICS



Figure 15

APPLICATION INFORMATION


NOTE A: The line should be terminated at both ends in its characteristic impedance $\left(R_{T}=Z_{O}\right)$. Stub lengths off the main line should be kept as short as possible.

Figure 17. Typical Application Circuit

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing | Pins | Package Qty | $\text { Eco Plan }{ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN65176BD | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN65176BDE4 | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN65176BDG4 | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN65176BDR | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN65176BDRE4 | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN65176BDRG4 | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN65176BP | ACTIVE | PDIP | P | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | Level-NC-NC-NC |
| SN65176BPE4 | ACTIVE | PDIP | P | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | Level-NC-NC-NC |
| SN75176BD | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BDE4 | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BDG4 | ACTIVE | SOIC | D | 8 | 75 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BDR | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no Sb/Br) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BDRE4 | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BDRG4 | ACTIVE | SOIC | D | 8 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN75176BP | ACTIVE | PDIP | P | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | Level-NC-NC-NC |
| SN75176BPE4 | ACTIVE | PDIP | P | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | Level-NC-NC-NC |
| SN75176BPSR | ACTIVE | SO | PS | 8 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN75176BPSRG4 | ACTIVE | SO | PS | 8 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb -Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb -Free products are suitable for use in specified lead-free processes.
Green (RoHS \& no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame
retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer:The information provided on this page represents Tl's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall Tl's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-001

D (R-PDSO-G8)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-012 variation AA.

## MECHANICAL DATA

PS (R-PDSO-G8)


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 .

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to Tl's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with Tl's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI .

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. Tl is not responsible or liable for such altered documentation.

Resale of Tl products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. Tl is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

## Products

## Applications

| Amplifiers | amplifier.ti.com | Audio | www.ti.com/audio |
| :--- | :--- | :--- | :--- |
| Data Converters | dataconverter.ti.com | Automotive | www.ti.com/automotive |
| DSP | dsp.ti.com | Broadband | www.ti.com/broadband |
| Interface | interface.ti.com | Digital Control | www.ti.com/digitalcontrol |
| Logic | logic.ti.com | Military | www.ti.com/military |
| Power Mgmt | power.ti.com | Optical Networking | www.ti.com/opticalnetwork |
| Microcontrollers | microcontroller.ti.com | Security | www.ti.com/security |
|  |  | Telephony | www.ti.com/telephony |
|  |  | Video \& Imaging | www.ti.com/video |
|  |  | Wireless | www.ti.com/wireless |

Mailing Address: Texas Instruments<br>Post Office Box 655303 Dallas, Texas 75265

Copyright © 2005, Texas Instruments Incorporated

